


<b>Search Notes</b> 	<b>Application/Control No.</b> 10730271	<b>Applicant(s)/Patent Under Reexamination</b> FURUKAWA, HIROKI
	<b>Examiner</b> Flores, Leon	<b>Art Unit</b> 2611

SEARCHED			
Class	Subclass	Date	Examiner
375	364, 316, 147, 340, 368	02/01/2007	LF
370	509	02/01/2007	LF

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE David Payne in regards to the patentability of claims 1, 20 & 21.	02/01/2007	LF
Checked for Double Patenting.	02/01/2007	LF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner